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FCP104N60F

N-Channel SuperFET® II FRFET® MOSFET

600 V, 37 A, 104 mΩ

Features

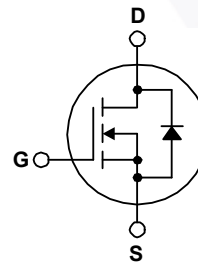
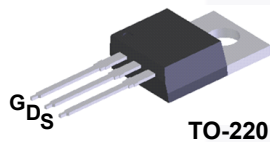
- 650 V @ $T_J = 150^\circ\text{C}$
- Typ. $R_{DS(on)} = 91\text{ m}\Omega$
- Ultra Low Gate Charge (Typ. $Q_g = 110\text{ nC}$)
- Low Effective Output Capacitance (Typ. $C_{oss(eff.)} = 313\text{ pF}$)
- 100% Avalanche Tested

Applications

- Lighting
- Solar Inverter
- AC-DC Power Supply

Description

SuperFET® II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SuperFET II MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications. SuperFET® II FRFET® MOSFET's optimized body diode reverse recovery performance can remove additional component and improve system reliability.



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted.

| Symbol | Parameter | FCP104N60F | Unit |
|----------------|--|--|------------------|
| V_{DSS} | Drain to Source Voltage | 600 | V |
| V_{GSS} | Gate to Source Voltage | - DC | ± 20 |
| | | - AC ($f > 1\text{Hz}$) | ± 30 |
| I_D | Drain Current | - Continuous ($T_C = 25^\circ\text{C}$) | 37 |
| | | - Continuous ($T_C = 100^\circ\text{C}$) | 24 |
| I_{DM} | Drain Current | - Pulsed (Note 1) | 114 |
| E_{AS} | Single Pulsed Avalanche Energy | (Note 2) | 809 |
| I_{AR} | Avalanche Current | (Note 1) | 6.8 |
| E_{AR} | Repetitive Avalanche Energy | (Note 1) | 3.57 |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 50 |
| | MOSFET dv/dt | | 100 |
| P_D | Power Dissipation | ($T_C = 25^\circ\text{C}$) | 357 |
| | | - Derate Above 25°C | 2.85 |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | $^\circ\text{C}$ |
| T_L | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds | 300 | $^\circ\text{C}$ |

Thermal Characteristics

| Symbol | Parameter | FCP104N60F | Unit |
|-----------------|---|------------|--------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case, Max. | 0.35 | $^\circ\text{C/W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient, Max. | 62.5 | |

Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|-------------|------------|---------|----------------|-----------|------------|----------|
| FCP104N60F | FCP104N60F | TO220 | Tube | N/A | N/A | 50 units |

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted.

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--------|-----------|-----------------|------|------|------|------|
|--------|-----------|-----------------|------|------|------|------|

Off Characteristics

| | | | | | | |
|--------------------------------|---|--|-----|------|-----------|--------------------|
| BV _{DSS} | Drain to Source Breakdown Voltage | $V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 25^\circ\text{C}$ | 600 | - | - | V |
| | | $V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 150^\circ\text{C}$ | 650 | - | - | |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 10\text{ mA}$, Referenced to 25°C | - | 0.67 | - | $V/^\circ\text{C}$ |
| BV _{DS} | Drain-Source Avalanche Breakdown Voltage | $V_{GS} = 0\text{ V}, I_D = 18.5\text{ A}$ | - | 700 | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$ | - | - | 10 | μA |
| | | $V_{DS} = 480\text{ V}, T_C = 125^\circ\text{C}$ | - | 16 | - | |
| I _{GSS} | Gate to Body Leakage Current | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$ | - | - | ± 100 | nA |

On Characteristics

| | | | | | | |
|---------------------|--------------------------------------|---|---|----|-----|------------|
| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$ | 3 | - | 5 | V |
| R _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 10\text{ V}, I_D = 18.5\text{ A}$ | - | 91 | 104 | m Ω |
| g _{FS} | Forward Transconductance | $V_{DS} = 20\text{ V}, I_D = 18.5\text{ A}$ | - | 33 | - | S |

Dynamic Characteristics

| | | | | | | |
|-----------------------|-------------------------------|--|---|------|------|----------|
| C _{iss} | Input Capacitance | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$ | - | 4610 | 6130 | pF |
| C _{oss} | Output Capacitance | | - | 3255 | 4330 | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 155 | 235 | pF |
| C _{oss} | Output Capacitance | $V_{DS} = 380\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$ | - | 74 | - | pF |
| C _{oss eff.} | Effective Output Capacitance | $V_{DS} = 0\text{ V to } 480\text{ V}, V_{GS} = 0\text{ V}$ | - | 313 | - | pF |
| Q _{g(tot)} | Total Gate Charge at 10V | $V_{DS} = 380\text{ V}, I_D = 18.5\text{ A}$ $V_{GS} = 10\text{ V}$ (Note 4) | - | 110 | 145 | nC |
| Q _{gs} | Gate to Source Gate Charge | | - | 24 | - | nC |
| Q _{gd} | Gate to Drain "Miller" Charge | | - | 44 | - | nC |
| ESR | Equivalent Series Resistance | Drain open | | 0.9 | | Ω |

Switching Characteristics

| | | | | | | |
|---------------------|---------------------|---|---|-----|------|----|
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 380\text{ V}, I_D = 18.5\text{ A}$ $V_{GS} = 10\text{ V}, R_{GEN} = 4.7\ \Omega$ (Note 4) | - | 34 | 78 | ns |
| t _r | Turn-On Rise Time | | - | 20 | 50 | ns |
| t _{d(off)} | Turn-Off Delay Time | | - | 102 | 214 | ns |
| t _f | Turn-Off Fall Time | | - | 5.7 | 21.4 | ns |

Drain-Source Diode Characteristics

| | | | | | | |
|-----------------|--|---|---|------|-----|---------------|
| I _S | Maximum Continuous Drain to Source Diode Forward Current | - | - | 37 | A | |
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | - | - | 114 | A | |
| V _{SD} | Drain to Source Diode Forward Voltage | $V_{GS} = 0\text{ V}, I_{SD} = 18.5\text{ A}$ | - | - | 1.2 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0\text{ V}, I_{SD} = 18.5\text{ A}$ | - | 144 | - | ns |
| Q _{rr} | Reverse Recovery Charge | $di/dt = 100\text{ A}/\mu\text{s}$ | - | 0.91 | - | μC |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. $I_{AS} = 6.8\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\ \Omega$, Starting $T_J = 25^\circ\text{C}$
3. $I_{SD} \leq 18.5\text{ A}, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$
4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Characteristics

Figure 1. On-Region Characteristics

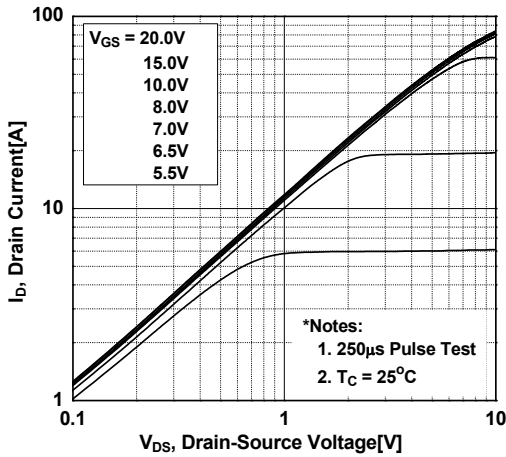


Figure 2. Transfer Characteristics

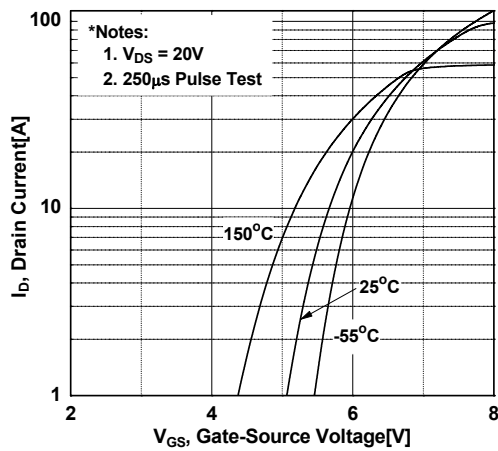


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

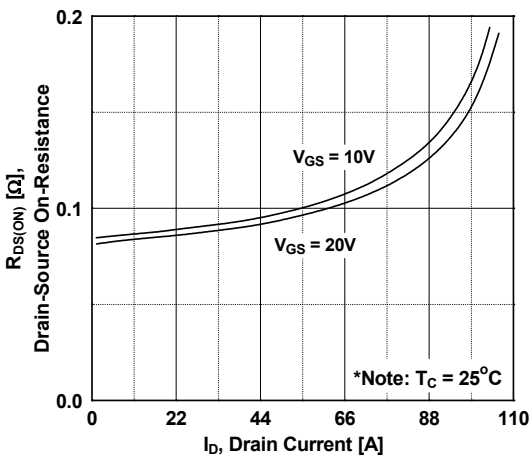


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

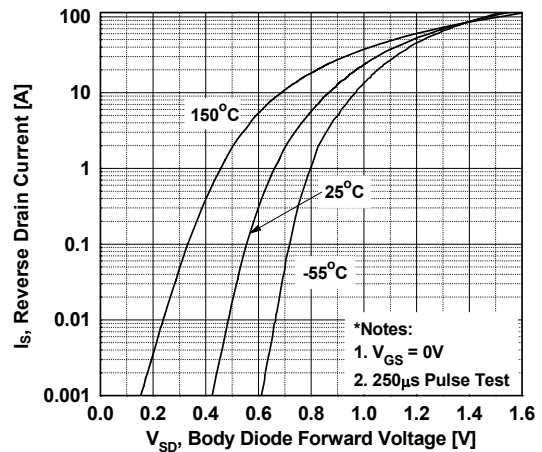


Figure 5. Capacitance Characteristics

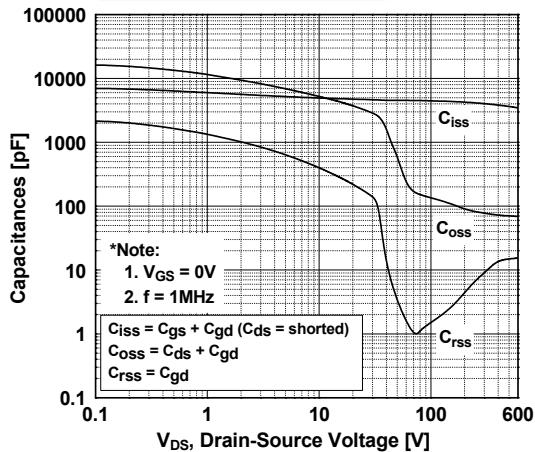
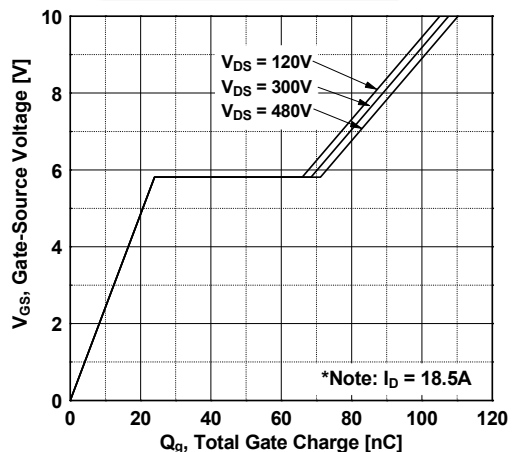


Figure 6. Gate Charge Characteristics



Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

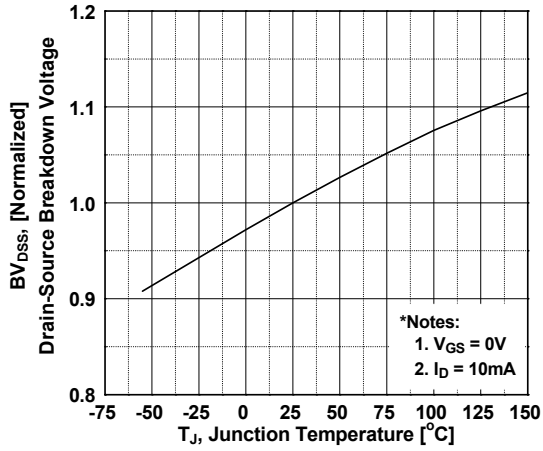


Figure 8. On-Resistance Variation vs. Temperature

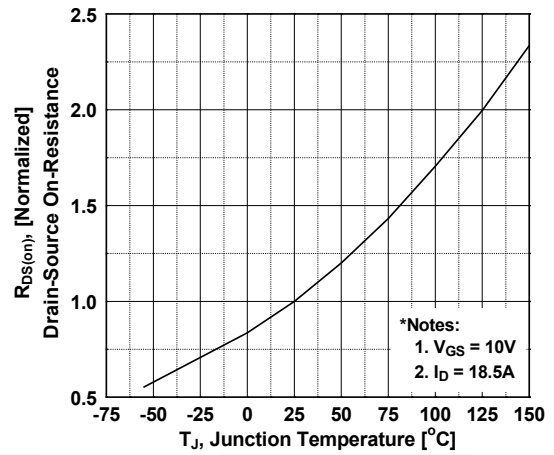


Figure 9. Maximum Safe Operating Area

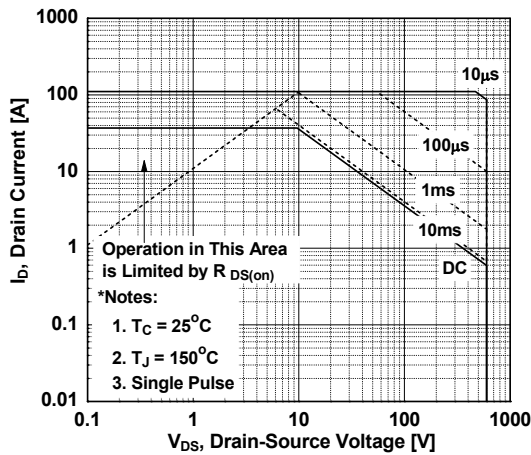


Figure 10. Maximum Drain Current vs. Case Temperature

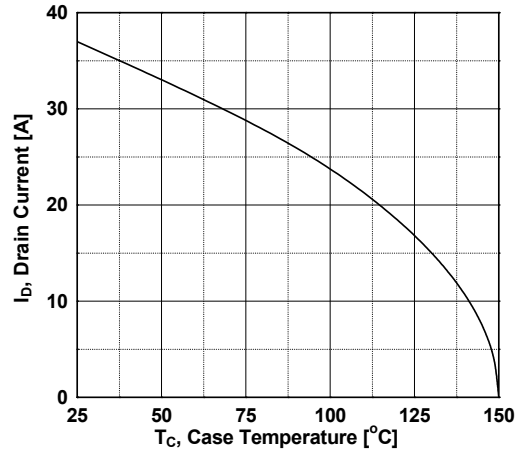


Figure 11. Transient Thermal Response Curve

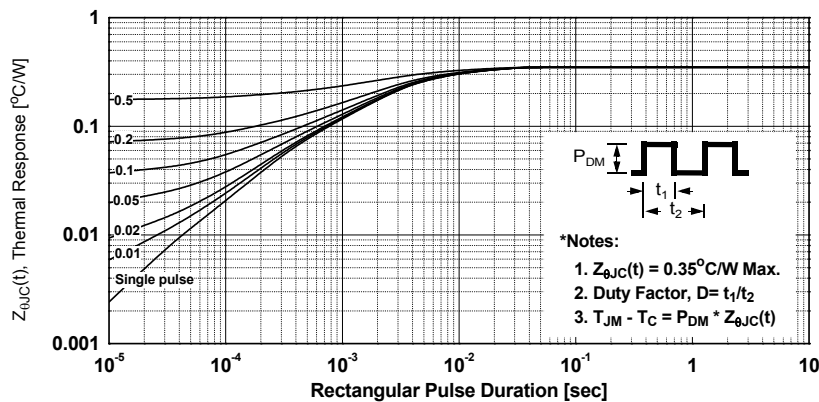


Figure 12. Gate Charge Test Circuit & Waveform

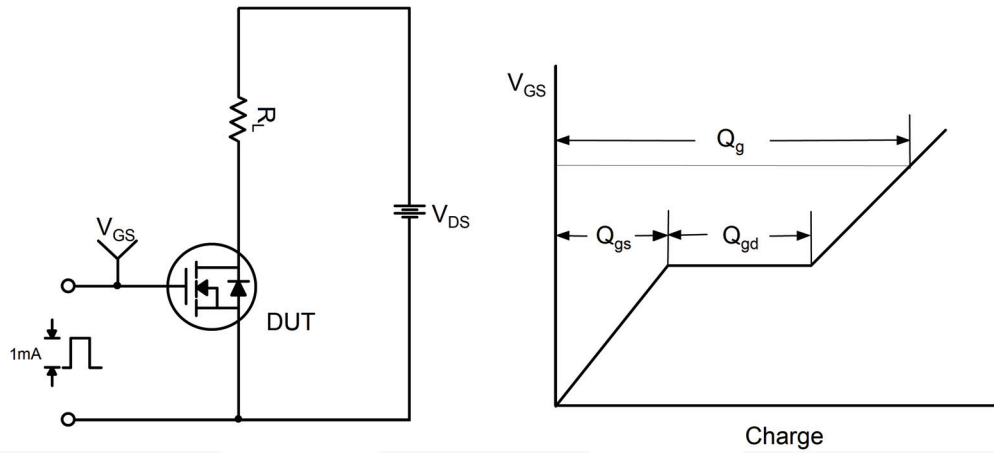


Figure 13. Resistive Switching Test Circuit & Waveforms



Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

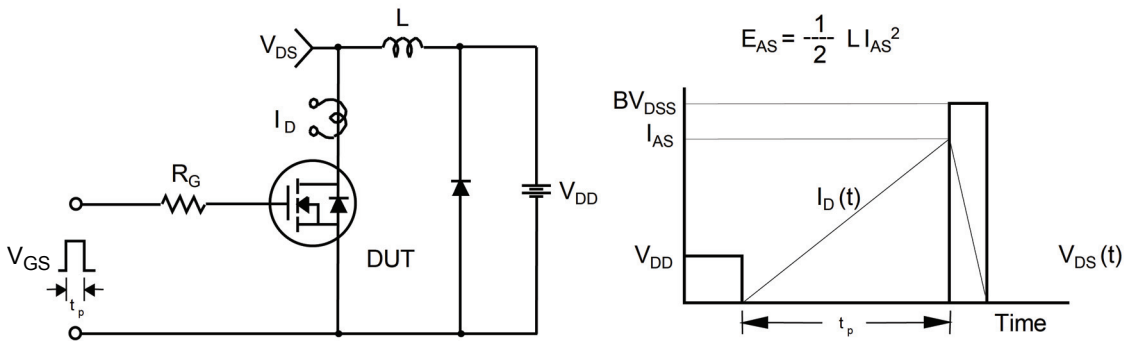
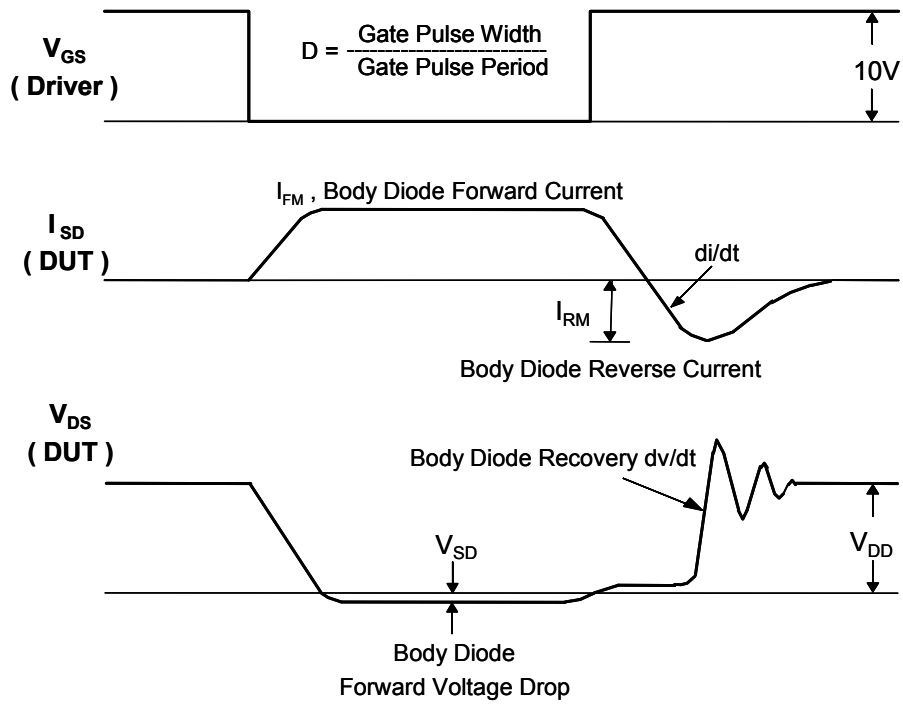
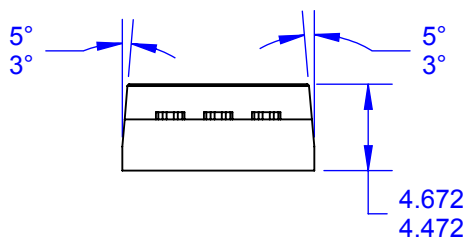
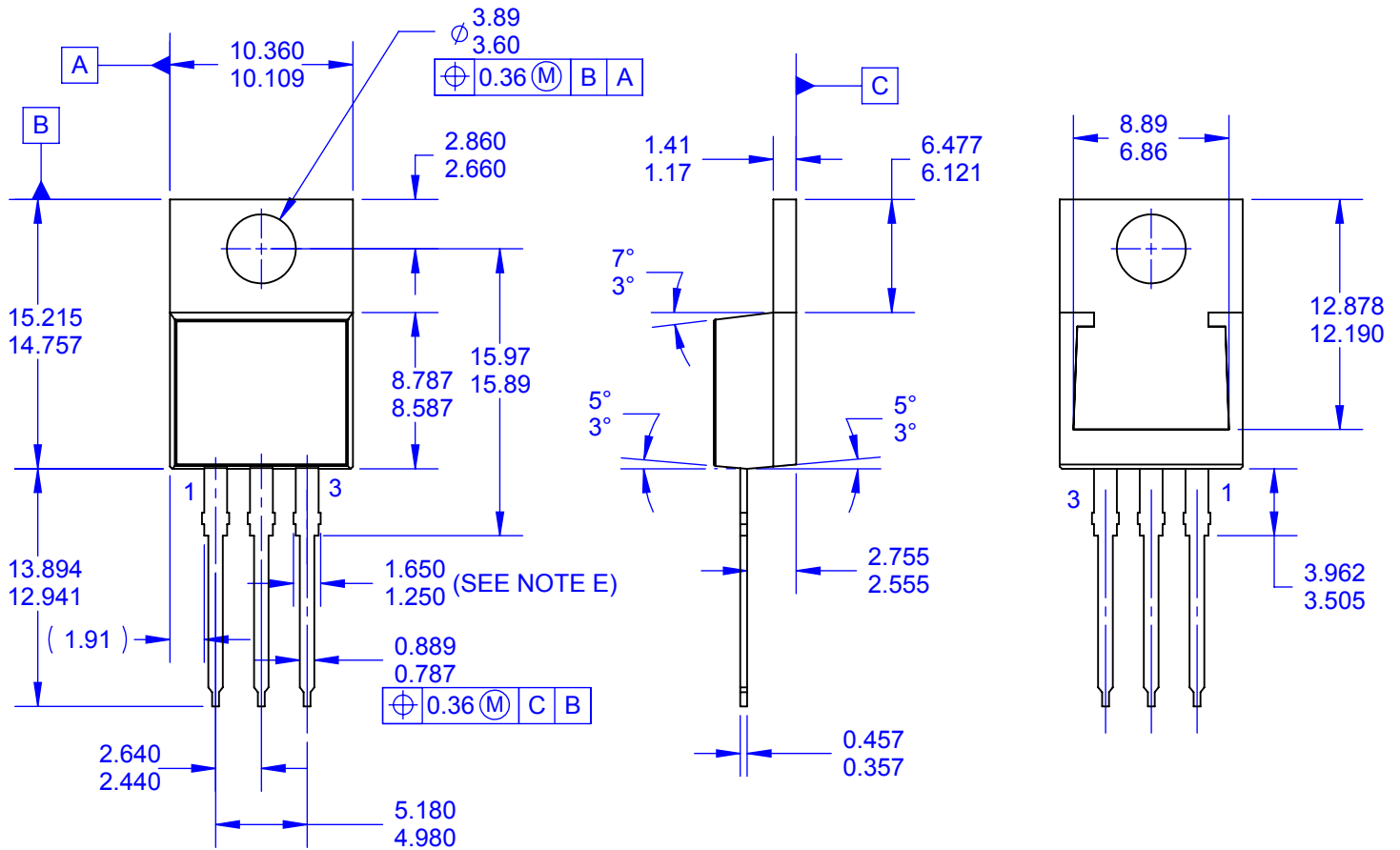


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





NOTES:

- A. PACKAGE REFERENCE: JEDEC TO220 VARIATION AB
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- E. MAX WIDTH FOR F102 DEVICE = 1.35mm.
- F. DRAWING FILE NAME: TO220T03REV4.
- G. FAIRCHILD SEMICONDUCTOR.

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